Outline of SPring-8 Public Beamlines under Construction (from the SPring-8 www site*)

*)SPring-8 Homepage address : http://www.spring8.or.jp/

JAERI-RIKEN SPring-8 Project Team Experimental Group

partial operation in Oct. 1997

full operation in Oct. 1997



Public Beamline

- BL01B1 XAFS
- <u>BL02B1</u> Crystal Structure Analysis
- <u>BL04B1</u> High Temperature Research
- <u>BL08W</u> High Energy Inelastic Scattering
- <u>BL09XU</u> Nuclear Resonant Scattering
- <u>BL10XU</u> Extremely Dense State
- <u>BL25SU</u> Soft X-ray Spectroscopy of Solid
- BL27SU Soft X-ray Photochemistry
- <u>BL39XU</u> Physicochemical Analysis
- <u>BL41XU</u> Bio-Crystallography

• Beamline for the Research and Development

• BL47XU R&D 1 full operation in Oct. 1997

JAERI Beamline

<u>RIKEN Beamline</u>

• Location of Beamlines

• Technical Information of Beamline

Insertion Device

kimura@spring8.or.jp Last modified : Oct 16,1996



BL01B1 —XAFS—

| Location : | BL-01 Bending Magnet #1 BL. | | |
|--------------------|-----------------------------|--|--|
| Person in Charge : | Tomoya URUGA (e-mail:urug | Tomoya URUGA (e-mail:urugat@spring8.or.jp) | |
| Subgroup : | Broad Energy Band XAFS | | |
| | Device | Bending Magnet, E _c =28.9keV | |
| | Tatalana | 220W(1, 100, A) | |

| Source Characteristics : | Total power | 220W (I=100mA) |
|--------------------------|----------------------------|---|
| | Power density | 1.5kW/mrad ² (I=100mA) |
| | Source size at 2% coupling | S _x =0.182mm, S _y =0.058mm, S _y =0.065mrad |

Optics :

| Distance from source | Optical Element | Function |
|--|-----------------|---|
| 32.7m | first mirror | collimation, higher harmonics elimination |
| 35.7m adjustable inclined double crystal monochron | | monochromatization, sagital focusing |
| 42.3m | second mirror | meridional focusing, higher harmonics elimination |

Energy range: 3.5-90keV

X-ray at Sample :

Energy resolution: DE/E=10⁻⁴ Photon flux: 10⁹-10¹¹ph/s

BM1 (02B1) : Crystal Structure Analysis BM3 (01B1) : XAFS



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The beamline called Crystal Structure Analysis is assigned to four subgroups, that is, Structural Phase transition, Highly Precise Molecular Crystallography, Diffuse Scattering and High-Resolution Powder groups. These groups handle materials to study structural aspects by fixed energy X-ray beam commonly. However, there are divergences in techniques such as crystal size, variation of atmospheres of samples, requirements of resolution function for the diffraction experiments and so on. The structural phase transition group became the group leader of this project to organize and converge the requirement for the system settled on the beamline.

The main concept of this beamline is to construct the machine as the general purpose for the diffraction experiments to include all of necessary demands of these four groups. They proposed the high flux and high energy beamline by using the radiation generated from a bending magnet in order.

- 1. to observe various weak diffraction such as diffuse scattering or superlattice diffraction utilizing the high flux radiation,
- 2. to collect a lot of diffraction data for precise structural analysis by utilizing high energy radiation and expanding the observable reciprocal lattice volume.

The experimental station is designing by the collaboration of four groups. The central part of the station is the sevenaxes diffractometer. It is very similar with the conventional six-axes diffractometer commonly used at many beamlines of synchrotron radiation facilities, and one extra two-theta axis is added. The purpose of the extra axis is to be specialized for the conventional structure analysis to give the high speed motor function. Off-center type chi-cradle is planned to put a cryostat, a furnace, a vacuum chamber and a spindle for powder sample on the phi-circle. Many other optional tools is be planning, for instance, a high precision solar slit, Imaging plate system for photographic method.

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BL04B1 — High Temperature Research —

| Location : | BL-04 Bending Magnet #1 BL. |
|-----------------------|---|
| Scientist in Charge : | Kazuhiko TSUJI (e-mail:tsuji@phys.keio.ac.jp) |
| In-house Staff : | Wataru UTSUMI (e-mail:utsumi@spring8.or.jp |

| Scientific Applications | X-ray diffraction for expanded fluids, liquids, and liquid alloys, XAFS, Small-angle x-ray scattering, Anomalous x-ray scattering (AXS) for multi-componet system. |
|--|---|
| Light Source Bending Magnet, 10-150keV | |
| Beam characteristics at sample | Energy range 10-150keV Energy resolution 5(eV), white Beam Size 1 × 1 mm² Beam Divergence vertical < 0.05 mrad, horizontal < 0.5mrad Photon flux 10¹⁰ photons/sec/mm²/0.1% b.w. Beam Stability 0.1 (mm) Others white x-ray and moochomatized x-ray |

Abstract

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The experimental hutches for the high temperature research will be built at the BL04B1 bending magnet beamline. This beamline has no monochrometer and white x-rays will be supplied for the experiment. Two scientific subgroups, high pressure mineral physics group and high temperature group, are planning to carry out their experiment in the two experimental stations tandemly built on this beamline.



Fig.1 Schematic view of transport channel of BL04B1

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High Pressure Mineral Physics

Research Subjects

- Structure of the Earth's Mantle and Core
- Magma and Molten Metal in the Earth's Interior
- In situ Observation of Diamond Synthesis

Facilities

• 1500 ton Large Volume Press with 6-8 Multi-Anvil Type High Pressure System 40 GPa, 2500 C

• Vertical and Horizontal Goniometer

The aim of the high pressure mineral physics group is to reveal the origin, evolution and present state of the internal structure of the Earth and other planets. For this purpose, various properties of planetary materials, such as iron, silicates, hydrogen and helium, will be investigated under high pressures and high temperatures. In particular, in situ x-ray diffraction experiment under high pressure and high temperature will be mainly carried out using the polychromatic x-rays from a bending magnet. The extreme pressure and temperature conditions corresponding to those of planetary interiors can be obtained with a multi-anvil type high pressure apparatus, which will be installed on this beamline. This high pressure apparatus has a 1500 ton ram-force uniaxial press with a cubic anvil type guide block, and is operated in the two-stage mode (so called 6-8 system) to reach the desired P-T conditions. This system has a capability of generating pressures up to 40 GPa and a temperature of 3000 K using a solid pressure medium. For the x-ray experiments, two single-axis goniometers (vertical and horizontal directions) are equipped by the high pressure press. The Ge solid state detector is used for the energy dispersive x-ray diffraction experiments.

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High Temperature

Research Subjects

- Structural Studies for Expanded Fluid Metals and Semiconductors
- Partial Structures in Multi-Component System
 - o Anomalous X-ray Scattering
 - o XAFS
- Structural Studies at Extremely High Temperatures

Facilities

• High Pressure Gas Vessel

Helium 2000 kg/cm², 1650 C

- Horizontal Goniometer
- Protection Wall

The high temperature group is planning to investigate the structural properties of disordered materials under high temperatures. One of the biggest topics is the structural studies of expanded fluid metals and semiconductors. When liquid metals are heated and pressure is applied to prevent boiling, significant density decreases can be achieved. When temperature is elevated at low pressure, a first-order phase transition from liquid to gas occurs accompanied with increasing pressure, and disappears at the critical point. At the pressure higher than this critical pressure, the volume of expanded fluid can be changed continuously in a wide range by heating. The structure of these expanded fluids, such as Hg and Se, will be investigated in a wide density range by the x-ray diffraction measurements and the small-angle x-ray scattering. In the experimental station, a high pressure gas vessel and an energy dispersive x-ray diffractometer will be installed. This high pressure vessel permits x-ray diffraction measurements at high temperature and pressure up to 1650 C and 2000 kg/cm². Since helium high pressure gas is used as pressure medium, all these facilities will be placed in small rooms surrounded by the protection wall built inside the hutch.

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PUBLIC BEAMLINE -

BL08W —High Energy Inelastic Scattering —

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| Location : | BL-08 Insertion Device BL. | | |
|---------------------------|--|---|---|
| Person in Charge : | Hitoshi YAMAOKA (e-mail:yamaoka@spring8.or.jp) | | |
| Subgroups : | High Energy Inelastic Scattering | | |
| | Magnetic C | Compton Scattering | |
| Scientific Applications : | High-resolu | ution Compton Scattering | |
| | High-energ | y Bragg Scattering | |
| | | Device | Elliptic multipole wiggler |
| | | l _u | 12cm |
| | N | | 37 |
| Source Characteristics : | Critical energy | | 42.6keV at K _y =11.2 |
| | Total Power | | 17.9kW at $K_y = 11.2$ |
| | Peak Power density | | 160kW/mrad ² at K _y =11.2 |
| | On-aixs degree of circular polarization | | 0.76 at 300keV, K_y =11.2, K_x =0.6 |
| | | Asymmetric Johanson mono | chromator, Si(771) |
| Station A : | X-ray energy: 300keV | | |
| (for Magnetic | Optics : | : Energy resolution: $DE/E = 5x10^{-3}$ | |
| Compton Scattering) | X-ray beam size at sample : 3mm(H)x1mm(W) | | |
| | | X-ray flux at sample: 5x10 ¹² ph/s at 300keV | |
| | | Doubly bent monochromator | , Si(400) |
| | | - | |

Station B :X-ray energy : 100-150keV(for High-resolutionOptics :Energy resolution: DE/E<1x10⁻³Compton Scattering)X-ray beam size at sample : 0.5mm(H)x0.5mm(W)

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X-ray flux at sample : 3.3x1013ph/s at 100keV

 Location :
 BL-09 Insertion Device BL.

 Person in Charge :
 Taikan HARAMI (e-mail:taikan@spring8.or.jp)

 Subgroups :
 Nuclear Resonant Scattering

 Surface and Interface Structure

| | Device | In-vacuum-type undulator |
|--------------------------|----------------|--|
| | l _u | 3.2cm |
| | N | 140 |
| Source Characteristics : | Tunable range | 6-80keV |
| | Brilliance | 1.5x1019 ph/s/mrad2/mm2/0.1%b.w. at 14.4keV |
| | Total Power | 1.31kW at 14.4keV |
| | Power density | 141kW/mrad ² at 14.4keV |
| | Source size | $S_x=0.41$ mm, $S_y=0.035$ mm, $S_x=0.017$ mrad, $S_y=0.0039$ mrad |

| Optics : | Distance from source | Optical Element | Description |
|----------|----------------------|---|---------------------------------|
| | 40m | Rotated-inclined double crystal monochromator | Energy resolution: DE/E $^{-4}$ |

XU2 (09XU) : Nuclear Resonant Scattering



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Source Characteristics :

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BL10XU — Extremely Dense State —

Location :BL-10 Insertion Device BL.Person in Charge :Kentaro SUZUYA (e-mail:suzuya@sp8sun.spring8.or.jp)Subgroups :Structural Properties of Extremely Dense Materials
High Brilliance XAFS

| Device | In-vacuum-type undulator |
|----------------|--|
| l _u | 3.2cm |
| Ν | 140 |
| Tunable range | >5keV |
| Brilliance | 2x10 ¹⁹ ph/s/mrad ² /mm ² /0.1%b.w. (I=100mA) |
| Total Power | 5kW |
| Power density | 300kW/mrad ² |

Optics :

| Distance from source | Optical Element | Function |
|----------------------|---|--------------------------------------|
| 36m | rotated-inclined double crystal monochromator | monochromatization of 5-60keV X-rays |
| 43m | double-flat mirror system (fixed exit double mirrors) | cut off energy: 10-20keV |
| 56m | Bragg Fresnel Lens | |

XU3 (10XU) : Extremely Dense State



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BL25SU — Soft X-ray Spectroscopy of Solid —

| Location : | В |
|--------------------|---|
| Person in Charge : | Y |
| Subgroups : | S |

BL-25 Insertion Device BL.Y. SAITOH (e-mail:ysaitoh@spring8.or.jp)Soft X-ray Spectroscopy of Solid

| | Device | Twin helical undulator Fast helicity modulation |
|---|-----------------------|---|
| | l_{u} | 120mm |
| | Ν | 12 |
| : | Tunable range | 0.5-3keV |
| | Brilliance | $6.65 \times 10^{17} \text{ ph/s/mrad}^2/\text{mm}^2/0.1\% \text{ b.w.}$ |
| | Total Power at 1keV | 667.5W |
| | Power density at 1keV | 0.862kW/mrad ² |
| | Source size | $S_x = 0.41 \text{ mm}, S_y = 0.035 \text{ mm}, S_x = 0.033 \text{ mrad}, S_y = 0.029 \text{ mrad}$ |

Source Characteristics

Optics :

X-ray at Sample :

| Distance from source | Optical Element | Function |
|----------------------|--|--|
| 38m | cylindrical mirror (M _h) | deflection and horizontal focusing |
| 40m | spherical mirror (M_v) | vertical focusing at the entrance slit |
| 50-71.9m | constant deviation monochromator with varied-space plane gratings (S_1 - M_1 or M_2 -G- S_2) | monochromatization |
| 76.4m, 80.9m | cylindrical mirrors (M_3, M_4) | focusing the beam onto the sample |

Energy resolution: E/DE > 10000Photon flux: $> 10^{13}$ ph/s Beam size: < 0.1mm



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BL27SU —Soft X-ray Photochemistry—

Location :BL-27 Insertion Device BL.Person in Charge :T. Sekiguchi (e-mail:tsekiguc@spring8.or.jp)Subgroups :Soft X-ray Photochemistry
Soft X-ray CVD

PUBLIC BEAMLINE -

| | High resolution molecular spectroscopy | | |
|---------------------------|--|--|--|
| | Photoionization dynamics by various correlation measurements | | |
| | Dynamics of inner-shell excited molecules | | |
| Scientific Applications : | Production and dynamics of novel core-excited states by SR(UR)-laser double resonance | | |
| | techniques | | |
| | Site-specific disso | ciation processes of adsorbed molecules | |
| | Growth of thin film | n of functional material | |
| | Micro fabrication by functional material etching | | |
| | Clarification of the reaction mechanics for deposition and process | | |
| | Device | Figure-8 undulator | |
| | l _u | 100mm | |
| | N | 44 | |
| Source Characteristics : | Tunable range | 0.5-5keV | |
| | Brilliance | 1.1x10 ¹⁸ ph/s/mrad ² /mm ² /0.1% b.w. at 500eV (I=100mA) | |
| | Total Power | 2.7kW at 1st harmonic(500eV) | |
| | Power density | 1.7kW/mrad ² at 1st harmonic(500eV) | |
| | Energy range: 0.5- | 2keV | |
| | Linearly polarized | | |
| | Photon flux: 10 ¹² pl | h/s | |
| X-ray at Sample : | Beam size: 0.5x0.5mm ² | | |
| | Resolution: $E/DE = 10000$ | | |
| | and microbeam capability of several-some tens micrometers diameter in the energy range | | |
| | of 0.5-5keV | | |
| | | | |
| | | | |
| | | | |

 Keep Out-Area
 Grating Monochromator
 Si
 Soft X-ray Photochemistry Beamline
 Minochromator
 Minochromator

 Soft X-ray Photochemistry Beamline
 Minochromator
 Si
 Si
 Si
 Si

 Readiation Shield Wall
 Electron Storage Ring
 Electron Storage Ring
 Si
 Si

 M_0 , M_0 : Horizontally deflecting mirror, M_1 : Vertically focusing mirror Monochromator/ S_1 : Entrance slit, S_2 : Exit slit, M_2 : Focusing mirror, G : Grating M_3 : refocusing mirror, Q : Sample position

tsekiguc@spring8.or.jp Last modified: Aug. 6, 1996 BL39XU — Physicochemical Analysis —

| Location : | BL-39 Insertion Device BL. | | |
|--------------------------|--|--|--|
| Person in Charge : | Shunji GOTO (e-mail:sgoto@spring8.or.jp) | | |
| | X-ray Magnetic Absorption and Scattering | | |
| Subgroups : | Spectrochemical Analysis | | |
| | Medical Application | | |
| | Device | In-vacuum-type undulator | |
| | Period length | 3.2cm | |
| | Peroid number | 140 | |
| Source Characteristics : | Tunable range | 5-70keV (fundamental-5th) | |
| | Brilliance | 2x10 ¹⁹ ph/s/mrad ² /mm ² /0.1%b.w. (I=100mA) | |
| | Total power | 11kW at 5keV, K=2.3 | |
| | Power density | 470kW/mrad ² | |

Optics :

| Distance from source | Optical Element | Function |
|----------------------|---|---|
| 36m | rotated-inclined double crystal monochromator | monochromatization, high heat load elimination |
| 44m | platinum coated plane mirror | higher harmonics elimination, horizontal deflection |

X-rays at Sample :

Energy range : 5-20keV Energy resolution : 2x10⁻⁴ Photon flux : 10¹⁵ph/s Beam divergence : < 0.1mrad Beam size : < 1mm



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BL41XU — Bio-Crystallography —

| Location : | BL41- Insertion Device BL. | |
|--------------------------|---|--------------------------|
| Person in Charge : | Nobuo KAMIYA (e-mail:nkamiya@postman.riken.go.jp) | |
| Subgroups : | Biological Structure | |
| | X-ray Structural Biology | |
| | Device | In-vacuum-type undulator |
| | Period length | 3.2cm |
| | Peroid number | 140 |
| Source Characteristics : | Tunable range | >9keV |

X-ray at sample :

Brilliance2x1019 ph/s/mrad2/mm2/0.1%b.w. (I=100mA)Total power5kWPower density300kW/mrad2

Optics :

| Distance from source | Optical Element | Function |
|----------------------|---|--|
| 35.9m | rotated-inclined double crystal monochromator | elimination of heat load, monochromatization |
| 39.5m | vertical focusing mirror | 3:1 demagnification |
| 44.0m | horizontal focusing mirror | 5:1 demagnification |

Energy range: 9-38keV Energy resolution: 2x10⁻⁴ (< 10⁻³ over 20keV) Photon flux: 10¹⁴ph/s Beam divergence: 0.1 mrad

Beam size: 0.1 mm



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